

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/809,399	YAMAKAWA ET AL.	
Examiner	Art Unit	
Dalena Tran	3664	

SEARCHED				
Class	Subclass	Date	Examiner	
701	25 - 37,39	12/106		
702	45,46			
106	183			
	184	712/1/07	DT	
700)	11,79			
714	25			
	37			
	46	/		
	Y			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
			,		
	-				
<u> </u>					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	12/4/07	DT
	- 17	
		E
	·	
18.		